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•	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/707,663	CHEN ET AL.
	Examiner	Art Unit
	SOPHIA VLAHOS	2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	150, 331, 350, 152, 351, 142	1/17/2007	sv	
455	437	1/17/2007	SV	
370	331, 350	1/17/2007	SV	
370	332, 503,	1/17/2007	sv	
370	506, 509	1/17/2007	sv	
375	364-367	1/17/2007	SV	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	1/17/2007	sv
IEEE Xplore	1/17/2007	SV
Yahoo,Google	1/17/2007	SV
Inventor Name Search (EAST, EPO, WIPO, PALM)	1/17/2007	sv
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